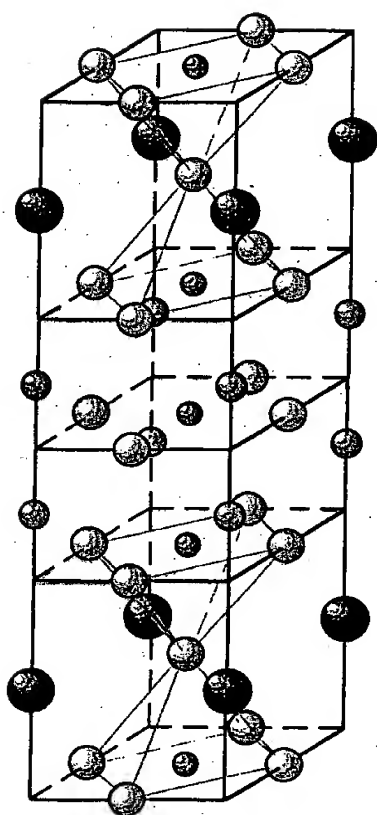
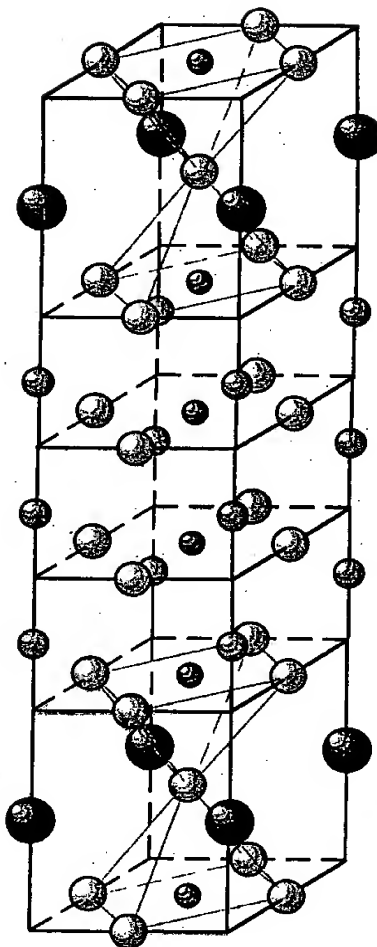
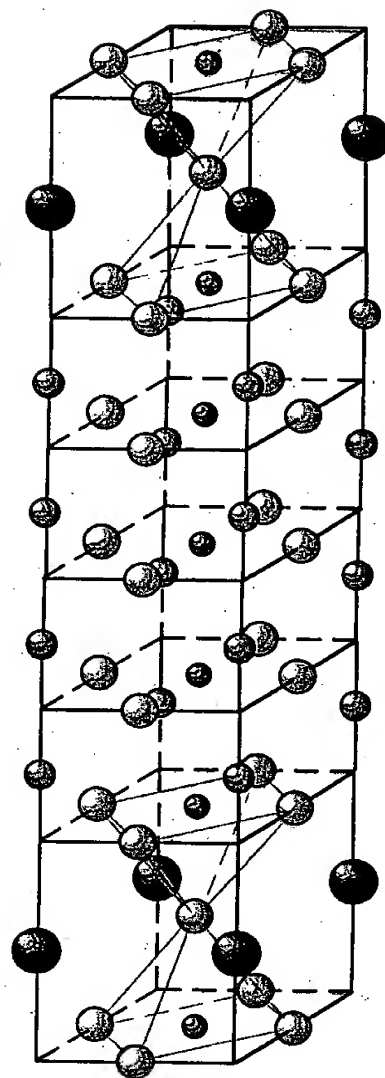
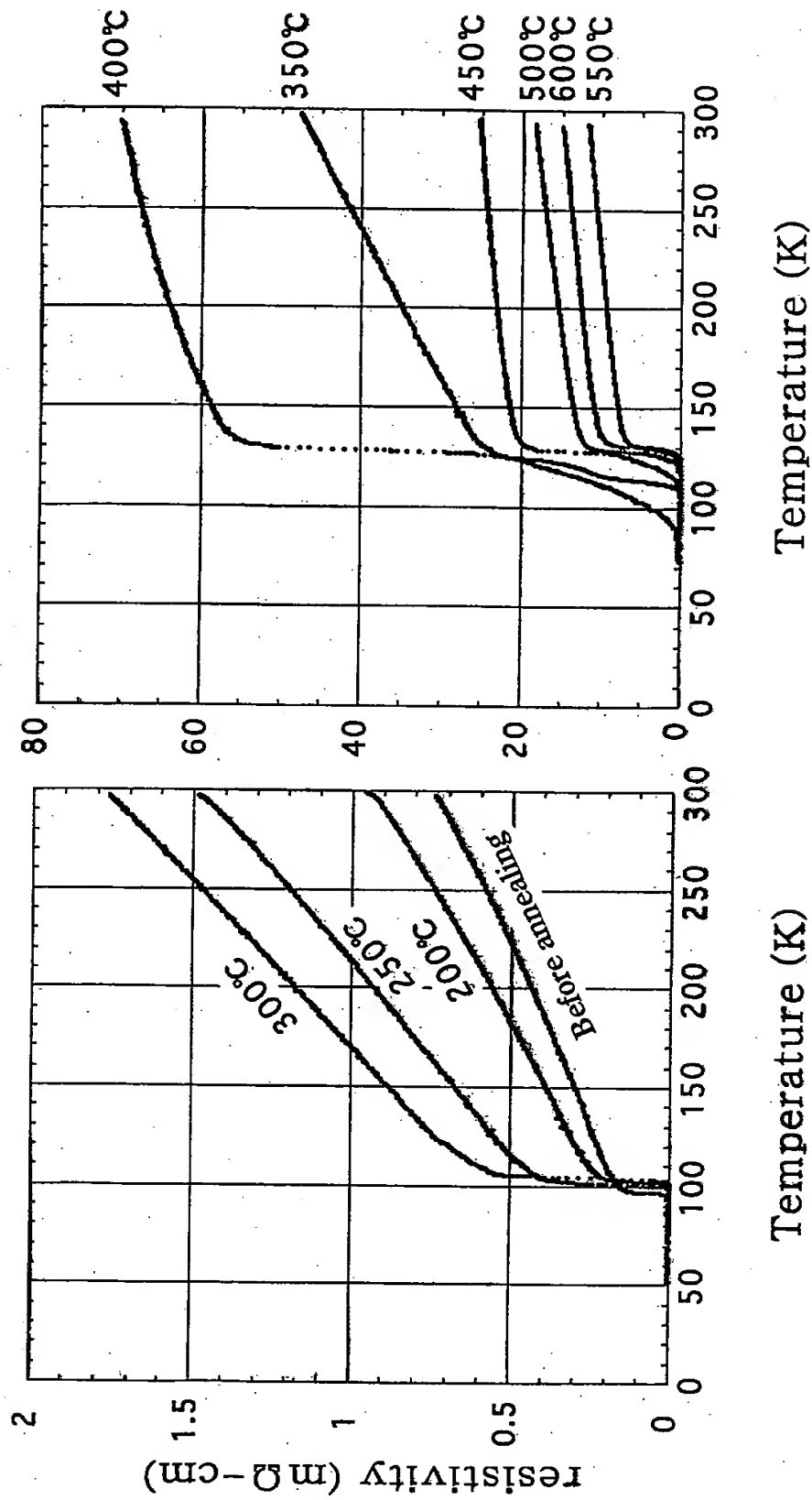
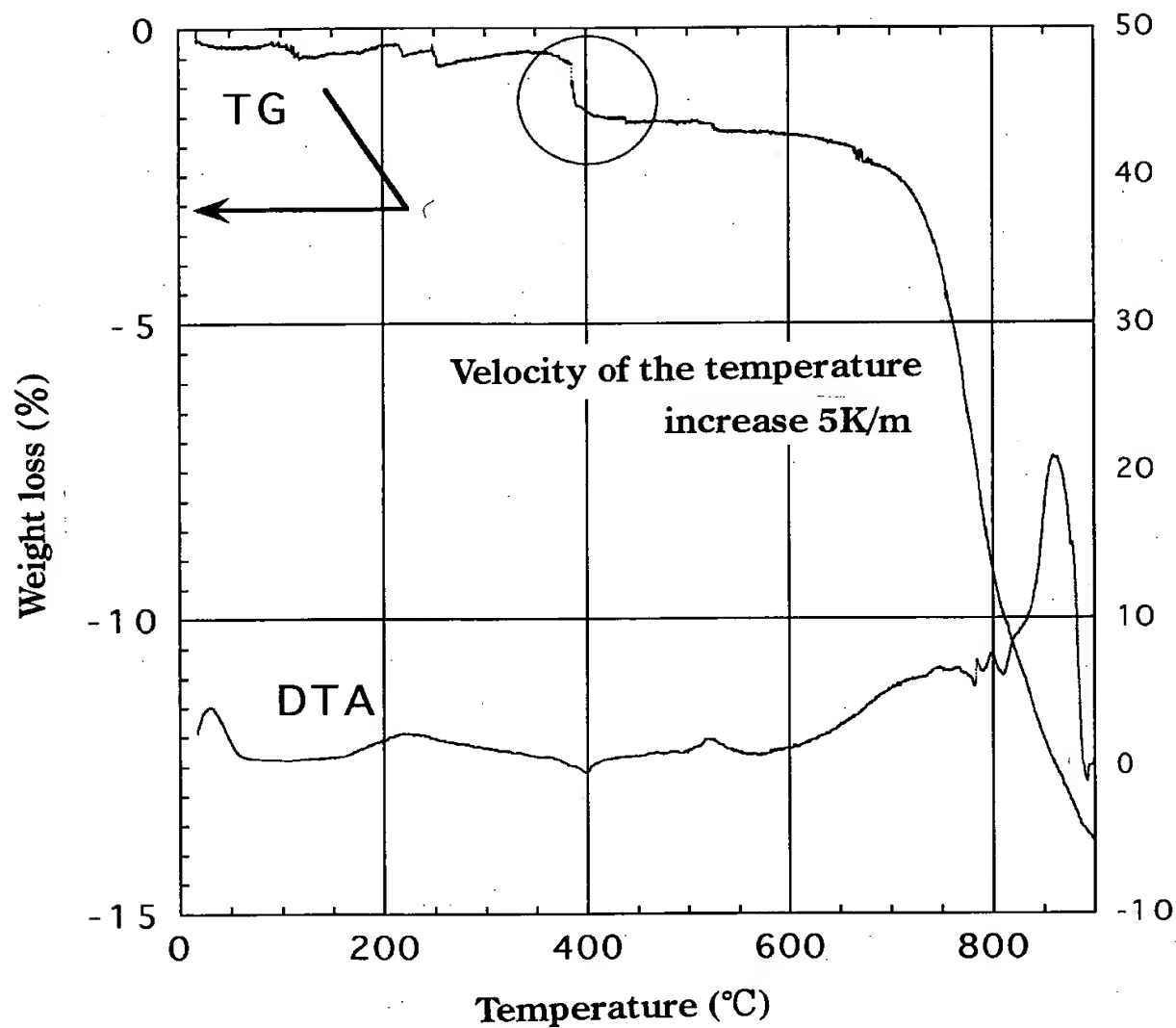
**Cu-1201****Cu-1212****FIG. 1A****FIG. 1B**

**Cu-1223****FIG. 2A****Cu-1234****FIG. 2B****Cu-1245****FIG. 2C**



The nitrogen-atmosphere-annealing temperature
dependency of the electrical resistivity

FIG. 3



Differential thermal analysis of (Cu, Tl)-1223

FIG. 4

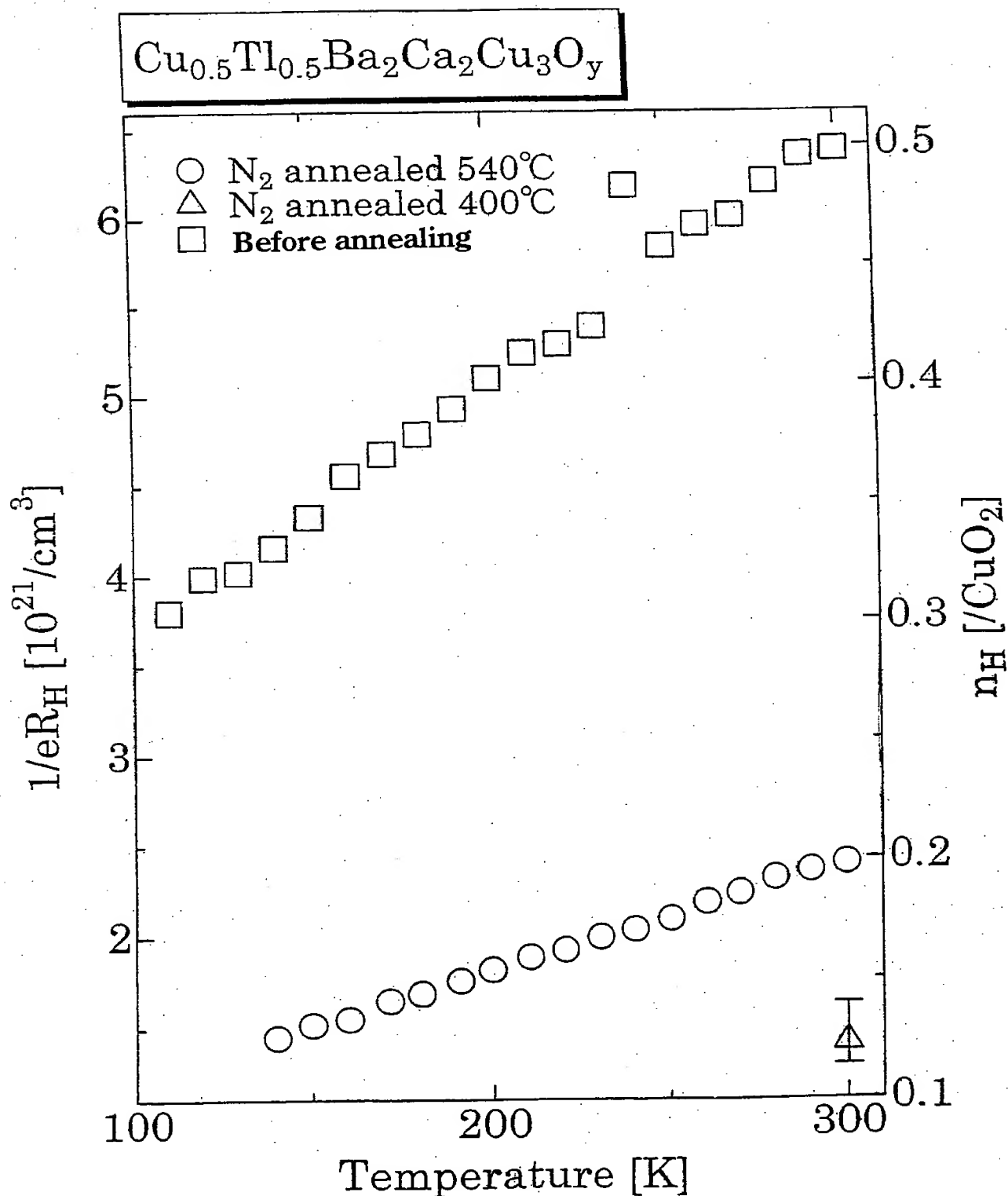


FIG. 5

Hole concentration for Cu found
from measurement of Hall coefficient

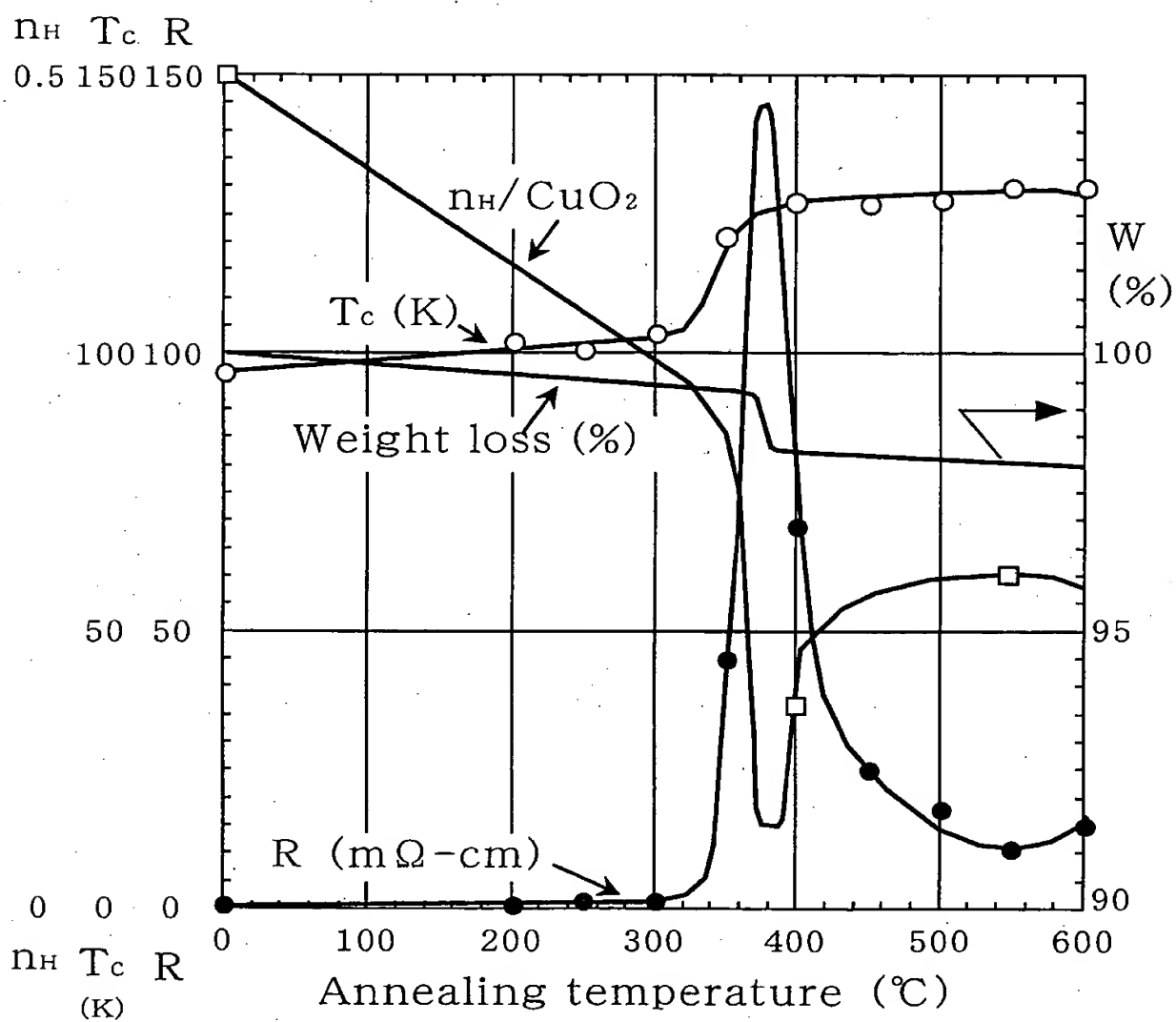


FIG. 6

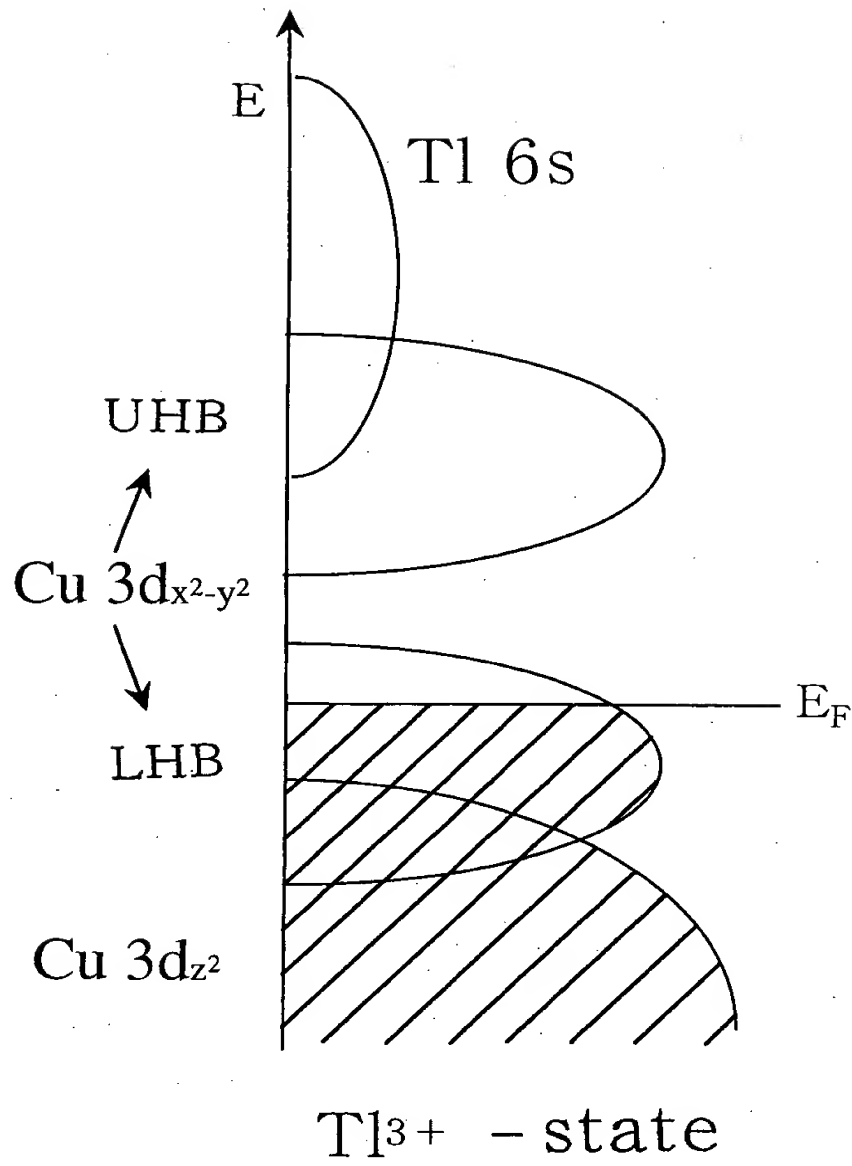


FIG. 7

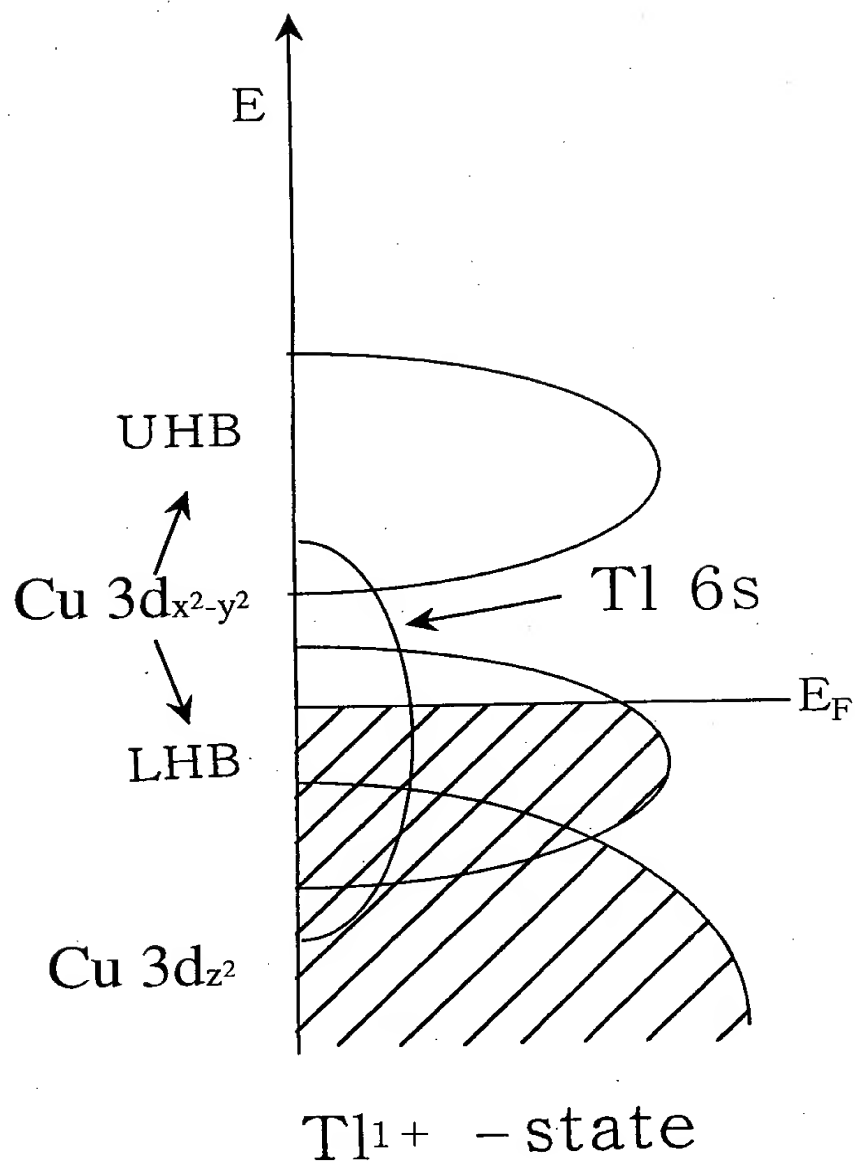


FIG. 8

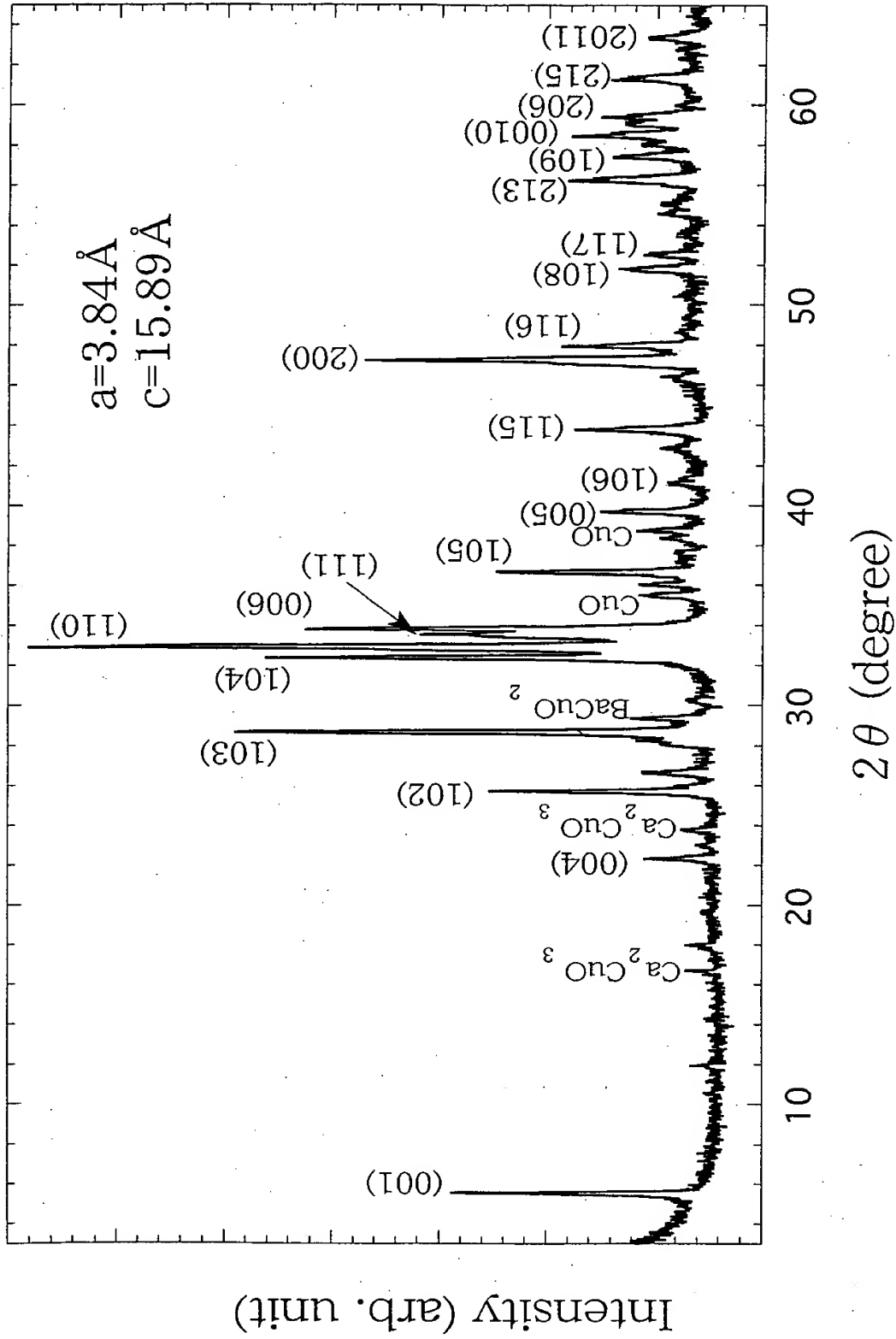


FIG. 9 (Cu,Tl)-1223 XRD